

INFORMATION DISCLOSURE CITATION

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Sheet 1 of 2
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ATTY. DOC. NO.
QA0235 NP
APPLICATION NO.
10/000,389
APPLICANT
LAUNAY ET AL.
FILING DATE
NOVEMBER 30, 2001

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE
SNW	AA	5,482,921	1/9/96	Seckinger et al.			
SNW	AB	5,605,877	2/25/97	Schafer et al.			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	OFFICE	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
SNW	AM	JP5540653 ✓	3/22/80	Japan			<input type="checkbox"/>	<input type="checkbox"/>
	AN	WO94/05668 ✓	3/17/94	PCT			<input type="checkbox"/>	<input type="checkbox"/>
	AO	WO00/13508 ✓	6/1/00	PCT			<input type="checkbox"/>	<input type="checkbox"/>
	AP	WO01/07052 ✓	2/1/01	PCT			<input type="checkbox"/>	<input type="checkbox"/>
SNW	AQ	WO01/30781 ✓	5/3/01	PCT			<input type="checkbox"/>	<input type="checkbox"/>

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent pages, Etc.)

SNW	AR	Issartel et al.; Eur. J. Med. Chem., 31, pp. 717-723 (1996) ✓
SNW	AS	Winstead et al.; J. of Med. Chem. p. 142 (1966) ✓
SNW	AT	Nam et al.; Arch. Pharm. Pharm. Med. Chem. pp. 268 - 270 (1997) ✓

EXAMINER

Sonya Wright

DATE CONSIDERED

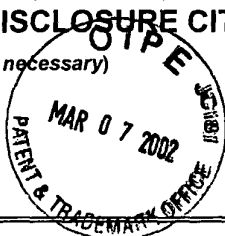
9-5-02

*EXAMINER: Initial of reference considered, whether or not citation is in conformance with MPEP 609: Draw a line through citation if not in conformance and not considered. Include a copy of this form with the next communication to applicant.

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PATENT AND TRADEMARK OFFICE



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		DOCUMENT NUMBER	DATE	OFFICE	CLASS	SUBCLASS	TRANSLATION YES NO	
<i>mw</i>	AM	EP0272594 ✓	6/29/88	Europe			<input type="checkbox"/>	<input type="checkbox"/>
	AN	EP1004583 ✓	5/31/00	Europe			<input type="checkbox"/>	<input type="checkbox"/>
	AO	WO98/39303 ✓	9/11/98	PCT			<input type="checkbox"/>	<input type="checkbox"/>
<i>mw</i>	AP	AU-A-82875/87 ✓	6/23/88	Australia			<input type="checkbox"/>	<input type="checkbox"/>
	AQ						<input type="checkbox"/>	<input type="checkbox"/>

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent pages, Etc.)

<i>mw</i>	AR	Corey et al.; J. of the Am. Chemical Society, 92:8, pp. 2476 - 2480 (1970) ✓
	AS	
	AT	

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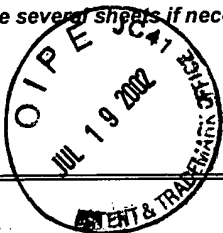
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FORM PTO-1449
(REV. 7-85)U.S. DEPARTMENT OF COMMERCE
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		DOCUMENT NUMBER	DATE	OFFICE	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
<i>SNW</i>	AM	WO02/08227A2	1/31/02	PCT			<input type="checkbox"/>	<input type="checkbox"/>
<i>SNW</i>	AN	DE2354086	5/16/74	German			<input type="checkbox"/>	<input checked="" type="checkbox"/>
<i>SNW</i>	AO	WO98/08813	3/5/98	PCT			<input type="checkbox"/>	<input type="checkbox"/>
	AP						<input type="checkbox"/>	<input type="checkbox"/>
	AQ						<input type="checkbox"/>	<input type="checkbox"/>

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent pages, Etc.)

<i>SNW</i>	AR	Abstract, XP-002196369, ComGenex Product List, Am. Chem. Soc.; 1999
<i>SNW</i>	AS	Abstract, XP-002196370, ComGenex Product List, Am. Chem. Soc.; 1999
<i>SNW</i>	AT	Abstract, XP-002196371, ComGenex Product List, Am. Chem. Soc.; 1999

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snw	AA	Abstract, XP-002196372, ComGenex Product List, Am. Chem. Soc.; 1999	/
	AB	Abstract, XP-002196373, ComGenex Product List, Am. Chem. Soc.; 1999	/
	AC	Abstract, XP-002196374, ComGenex Product List, Am. Chem. Soc.; 1999	/
	AD	Abstract, XP-002196375, ComGenex Product List, Am. Chem. Soc.; 1999	/
	AE	Abstract, XP-002196376, ComGenex Product List, Am. Chem. Soc.; 1999	/
	AF	Abstract, XP-002196377, ComGenex Product List, Am. Chem. Soc.; 1999	/
	AG	Abstract, XP-002196368, Chem. Abstracts Service, Vol 101, No. 110818, 1984	/
	AH	Migawa et al. Organic Letters, Vol 2, No. 21, pp. 3309 - 3311, 2000	/
	AI	Deprez et al., Tetrahedron: Asymmetry, Vol. 2, No. 12, pp. 1189 - 1192, 1991	/
	AJ	Wittland, et al. Synthesis (11), pp. 1291- 1295 , 1997	/
snw	AK	Deprez et al., Tetrahedron Vol. 49, No. 18, pp. 3781 - 3792, 1993	/
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